



# Microbeam Analysis Society

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## MESSAGE FROM THE PRESIDENT



**Ian M. Anderson**  
Microbeam Analysis Society

On behalf of the membership of the Microbeam Analysis Society (MAS), welcome to Microscopy and Microanalysis 2008, held August 3–7, 2008 in Albuquerque, NM. The Microscopy and Microanalysis (M&M) meeting was established in 1996 as the joint annual meeting of the Microscopy Society of America (MSA) and MAS, and has served as the annual meeting of the International Metallographic Society (IMS) since 2002. I thank my counterparts in these societies, MSA President Bill Gunning and IMS President Dave Fitzgerald, with whom I've worked closely, for all their time and effort in putting together this meeting. I also welcome members of the International Society for Analytical Cytology (ISAC; J. Paul Robinson, President), which is sponsoring a substantial Pre-Meeting Congress during the weekend prior to M&M 2008 and a symposium during the week.

Working with representatives of the Program Committee over the past months, I have been impressed with the extent to which the varied programming interests of the three joining societies have been fashioned into a single integrated program. I offer congratulations to MSA Program Chair John Henry Scott, MSA Vice-Chair Janet Woodward, MAS Co-Chair Paul Carpenter, and IMS Co-Chair Jaret Frafjord for this remarkable accomplishment. Thanks also to this year's Program Committee "Junta," and for the the annual efforts in the production of the program by Stuart McKernan and Nestor Zaluzec,

## MAS CALENDAR OF EVENTS 2008

### Sunday, August 3, 2008

MAS Council Meeting (Ruidoso Room),  
7:30 AM–5:30 PM  
MAM Editors' Board Meeting (Zuni Room),  
3:00–5:00 PM  
Opening Reception, 6:30–9:30 PM (Rio Grande Zoo,  
ticket required, see Page 19)

### Monday, August 4, 2008

MAM Editorial Board Meeting (Zuni Room),  
7:15–8:15 AM  
M&M 2008 Program Planning Meeting (Zuni Room),  
3:30–5:00 PM

### Tuesday, August 5, 2008

M&M 2009 Call for Papers Meeting (Zuni Room),  
10:00 AM–12:00 PM  
MAS Presidential Happening (Aztec Room),  
12:15–1:15 PM

### Wednesday, August 6, 2008

MAS Affiliated Regional Societies Luncheon  
(Cochiti Room), 12:15–1:15 PM  
MAS Business Meeting (Aztec Room), 5:15–6:15 PM  
MAS Members Social, 6:30 PM  
(ticket required; visit MAS Booth for information)

### Thursday, August 7, 2008

MSA/MAS Sustaining Members Breakfast  
(Tesuque Room), 7:00–9:00 AM

database gurus extraordinaire, *EXPO* Editor Richard Edlmann, and *Proceedings* Editor John Shields. The hospitality and local expertise of the Local Arrangements Committee, chaired by Joe Michael, have been instrumental in bringing together many aspects of the meeting. Finally, let me convey a warm welcome to Nicole Guy, our new meeting manager. Many of you will notice improvements during the week that are a result of Nicole's professional expertise.

One of my great honors of serving as society President is the bestowing of Distinguished Scholar Awards. This year's establishment of the Chodos Fund will help to bring students to the annual meeting for years to come. I hope that you will have the opportunity to attend several of the presentations given by this year's student award winners, whose research illustrates the breadth and quality of research that our society stands for. Please make an effort to meet them and invite them into the life of the Microbeam Analysis Society.



## MAS COUNCIL OFFICERS 2007

### Executive Council

President Ian M. Anderson  
 President Elect Catherine Johnson  
 Past President Paul G. Kotula  
 Secretary Scott D. Davila  
 Treasurer James J. McGee

Directors *2006–2008*  
 John H. Fournelle  
 Masashi Watanabe

*2007–2009*  
 Luke N. Brewer  
 Kristin L. Bunker

*2008–2010*  
 Stuart McKernan  
 Nicholas W. M. Ritchie

### Appointed Officers and Committee Chairs

MAS Business Office William S. Thompson

*2005–2008*  
 Membership Services Louis M. Ross  
 Strategic Planning Paul K. Carpenter  
 Sustaining Members Catherine Johnson

*2006–2009*  
 Computer Activities Scott A. Wight  
 Education Phillip E. Russell  
 International Liaison Joseph R. Michael  
*MicroNews* Editor Ryna B. Marinenko

*2007–2010*  
 Affiliated Regional Societies Paul F. Hlava  
 Archivist John H. Fournelle  
 Corporate Liaison Vernon E. Robertson  
 Finance C. Gordon Cleaver

## MAS PAST PRESIDENTS

1968 L. S. Birks	1982 R. L. Myklebust	1996 D. E. Johnson
1969 K. F. J. Heinrich	1983 R. Bolon	1997 J. R. Michael
1970 R. E. Ogilvie	1984 D. C. Joy	1998 R. B. Marineko
1971 A. A. Chodos	1985 D. E. Newbury	1999 J. J. Friel
1972 K. Keil	1986 C. G. Cleaver	2000 C. E. Lyman
1973 D. R. Beaman	1987 C. E. Fiori	2001 R. W. Linton
1974 P. Lublin	1988 W. F. Chambers	2002 G. P. Meeker
1975 J. W. Colby	1989 D. B. Wittry	2003 E. S. Etz
1976 E. Lifshin	1990 A. D. Romig, Jr.	2004 P. K. Carpenter
1977 J. I. Goldstein	1991 J. T. Armstrong	2005 I. H. Musselman
1978 J. D. Brown	1992 D. B. Williams	2006 R. Gauvin
1979 D. F. Kyser	1993 T. G. Huber	2007 P. G. Kotula
1980 O. C. Wells	1994 J. A. Small	
1981 J. R. Coleman	1995 J. J. McCarthy	

## MAS SUSTAINING MEMBERS

4pi Analysis, Inc.	Energy Beam Sciences, Inc.	Materials Analytical Services, Inc.
Advanced MicroBeam, Inc.	FEI Company	Micron, Inc.
Bruker AXS Microanalysis	Gatan, Inc.	Oxford Instruments, Inc.
Cameca Instruments, Inc.	Geller MicroAnalytical Laboratory, Inc.	Probe Software, Inc.
Carl Zeiss SMT	Hitachi High Technologies America, Inc.	TEC Laboratories, Inc.
Denton Vacuum, LLC	IXRF Systems, Inc.	Ted Pella, Inc.
EDAX, Inc.	JEOL USA, Inc.	Thermo Fisher Scientific, Inc.
Electron Microscopy Sciences/ Diatome US	Lehigh University	



### **Peter Duncumb Award for Excellence in Microanalysis**

The Duncumb Award recognizes outstanding achievement over a sustained period of time in the field of microanalysis through technical accomplishment, leadership, and educational and professional activities. The award winner is chosen through nomination by the MAS membership and selection by vote of MAS Council.

### **Presidential Service Award**

This award honors a member of MAS for outstanding volunteer service to the society over a sustained period of time. The award winner is chosen annually by the MAS President.

### **Presidential Science Award**

This award honors a senior scientist for outstanding technical contributions to the field of microanalysis over a sustained period of time. The award winner is chosen annually by the MAS President.

### **K. F. J. Heinrich Award**

This award honors a scientist under the age of forty for distinguished technical contributions to the field of microanalysis. The award winner is chosen annually by the MAS President.

### **MAS Distinguished Scholar Awards**

These awards are presented annually to students presenting high quality technical papers with significant microanalysis

content at the annual meeting. The award is comprised of complimentary registration and significant funds to defray travel expenses to attend the meeting. Application is accomplished by requesting consideration for a student award during the paper submission process. Qualified applicants must be full-time students at an accredited educational institution, must be first author of the paper submitted for consideration, and must present the paper in person at the meeting. MAS Distinguished Scholars receive invitations to attend MAS-sponsored functions throughout the week of the annual meeting, including the Presidents' Reception and the MAS Social. The award winners are chosen annually by the MAS President.

### **MAS Outstanding Paper Awards**

These awards are presented annually to the authors of outstanding papers from the previous annual meeting in each of four categories. The four awards are as follows:

- Birks Award, for best contributed paper;
- Macres Award, for best instrumentation or software paper;
- Cosslett Award, for best invited paper; and
- Castaing Award, for best student paper.

Candidates for the MAS Outstanding Paper Awards are nominated, through consultation with symposium organizers and the MAS membership, by the MAS Directors in their final year of service at the time of the meeting, then approved by vote of MAS Council.



**Duncumb Award for Excellence in Microanalysis**  
Joseph I. Goldstein

**Joseph I. Goldstein** is a scientist, educator and administrator internationally known for his work in the development of X-ray techniques in electron microscopy to determine the chemistry of small regions of solid materials, ranging from cubic micrometers to cubic nanometers, and in the field of meteoritics, the study of meteorites and other extraterrestrial materials. Working with colleagues, he has developed methodologies and instrumentation for electron microscopes to improve spatial resolution, to minimize the effects of spurious radiation, and to improve light element and trace element analysis, and used these techniques to measure diffusion coefficients and phase diagrams, to study phase growth and ternary diffusion effects in iron base alloys and various diffusion coatings, and to understand the metal phases in meteorites and lunar samples. Dr. Goldstein has written over 200 technical papers. He has been awarded the Presidential Science Award of the Microbeam Analysis Society and the Leonard Medal of the Meteoritical Society.

Joe Goldstein has shown active leadership in his fields of study. He founded the Lehigh Microscopy School, the most influential and comprehensive education program in electron microscopy and microanalysis, and has co-authored textbooks that have become the recognized standards in the field. As a university administrator, he has overseen the development of several major research centers, the improvement of undergraduate engineering curricula, and the promotion of information technology education. He has served as president of the Microbeam Analysis Society and The Meteoritical Society.



**Presidential Science Award**  
Thomas F. Kelly

**Thomas F. Kelly**, professor of Materials Science and Engineering at the University of Wisconsin-Madison until September 2001, founded Imago Scientific Instruments to commercialize the atom-probe microscope—a technology that enables researchers to analyze materials such as computer chips at the atomic scale. His invention, the Local Electrode Atom Probe (LEAP), captures an atom-by-atom “picture” of a material and renders that image on a computer screen in 3D.

Thomas F. Kelly received a B.Sc. in Mechanical Engineering with highest honors from Northeastern University in 1977 and a Ph.D. in Materials Science from the Massachusetts Institute of Technology in 1981. He joined the faculty of the University of Wisconsin-Madison in January 1983, becoming a Full Professor in 1994. Tom served as Director of the Materials Science Center from 1992 to 1999.

Tom Kelly has been active in the fields of microscopy and microanalysis, and their applications to rapidly solidified, electronic, and superconducting materials for over 30 years. He has published over 125 papers and 6 patents in these fields over this period. Dr. Kelly is an authority on microstructural characterization. He is expert in most methods and techniques of transmission electron microscopy, scanning electron microscopy, and atom probe microscopy and has brought innovations to their instrumentation and practice. Tom has served as a Director of the Microscopy Society of America. He is currently President of the International Field Emission Society.



**K. F. J. Heinrich Award**  
Paul G. Kotula

**Paul G. Kotula** is a Principal Member of Technical Staff in the Materials Characterization Department at Sandia National Laboratories in Albuquerque, NM. Paul received his B.S. from Cornell University and Ph.D. from the University of Minnesota, both in Materials Science and Engineering. Before joining Sandia, he was a Director-Funded Postdoctoral Fellow at Los Alamos National Laboratory. His work at Sandia includes analytical electron microscopy support for microelectronic and micro-electromechanical device development, welding, brazing, soldering, forensics, process feedback, failure analysis, and 3D materials characterization and microanalysis. He is the Principal Investigator for a project for the Department of Homeland Security on the development of better analytical techniques for forensics and attribution of bio-weapon materials and has also helped build a world-renowned research program on acquisition and automated multivariate statistical analysis of spectral image data sets. The software developed from this work for x-ray microanalysis is commercially available from Thermo Fisher Scientific and is now in over 200 labs worldwide. Paul's work has also garnered several awards over the years, among them an R&D 100 Award in 2002, two MAS Outstanding Paper Awards (Macres, 2000; Birks, 2004), and two Best Analytical Techniques paper of the year in the society journal, *Microscopy and Microanalysis* (2003, 2006).

Paul has been an Adjunct Professor in the Department of Materials Science and Engineering at North Carolina State University since 2001 and has authored or co-authored over 50 journal articles on a wide variety of topics involving electron microscopy and microanalysis as well as two patents and two book chapters. His work has been featured on two journal covers and he has given over 10 invited/keynote presentations at international meetings and over 30 at domestic meetings.



**Presidential Service Award**  
Louis M. Ross

**Louis M. Ross** is the Senior Electron Microscope Specialist in the Electron Microscopy Core Facility (EMCF) and Adjunct Instructor in the Department of Physics and Astronomy at the University of Missouri (MU) in Columbia. Lou received his Bachelors degree in Geology at Washington University in St. Louis in 1975. As an undergraduate research assistant during his senior year, he was introduced to scanning electron microscopy and X-ray microanalysis (SEM/EDS) in the McDonnell Center for the Space Sciences, where he remained as a research technician through 1982. In that year, Lou moved to MU to oversee the electron microprobe laboratory in the Department of Geological Sciences. In his years at MU, he has overseen the consolidation of electron microscopy operations, culminating with the present EBCF in 2000. Lou now teaches two graduate courses in SEM/EDS at MU.

Lou Ross has had a strong record of involvement in Microbeam Analysis Society (MAS) and its affiliated regional societies (AReS) since he joined MAS in 1985. In 1990, he co-founded MIKMAS (Missouri, Illinois, and Kansas MAS) and ten years later helped to orchestrate its merger with another regional society, forming the Central States Microscopy and Microanalysis Society (CSMMS); he served two terms as President of both MIKMAS and CSMMS. Lou has served as MAS Membership Services Chair for the past ten years, during which time he has been instrumental in fostering communications between the MAS Council and its members along with interacting with the various MAS committees while overseeing all aspects of the membership operations. In 2008, he will begin a three-year term as MAS Sustaining Membership Chair.



### MAS DISTINGUISHED SCHOLARS

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- P. Bajaj** University of Texas at Dallas  
*Correlative Microscopic and Spectroscopic Characterization of Carboxylated Single-Walled Carbon Nanotubes*
- J. J. Cha** Cornell University  
*Tunneling Magnetoresistance and B Diffusion in CoFeB/MgO/CoFeB Magnetic Tunnel Junctions Characterized by STEM-EELS*
- M. Eddy** University of Michigan  
*Microbeam Analysis of Plasma Effects in Synthetic Mica-Like Compound*
- H. C. Floresca** University of Texas at Dallas  
*New FIB Fold-Out Method for TEM Cross-Section Sample Preparation*
- B. R. Gipson** University of California at Davis  
*2dx—Automated 3D Structure Reconstruction from 2D Crystal Data*
- J. M. LeBeau** University of California at Santa Barbara  
*Quantitative HAADF-STEM and EELS*
- B. McMorran** University of Arizona  
*Very Low Energy TEM Diffraction of Nanostructures*
- W. D. Pyrz** University of Delaware  
*Using Aberration-Corrected STEM Imaging to Explore Chemical and Structural Variations in the M1 Phase of the MoVNbTeO Oxidation Catalyst*
- W. Walkosz** University of Illinois at Chicago  
*Investigation of the Atomic Structures of  $\text{Si}_3\text{N}_4/\text{CeO}_{2-\delta}$  Interfaces using Atomic Resolution Z-Contrast Imaging and EELS Combined with First-Principles Methods*
- H. L. Xin** Cornell University  
*Controlling Channeling Effects in Aberration-Corrected STEM Tomography*

### MICROBEAM ANALYSIS SOCIETY OUTSTANDING PAPER AWARDS FROM M&M 2007

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#### **Birks Award-Best Contributed Paper**

S. D. Davilla; 4pi Analysis, Inc.  
*Event Streamed Spectrum Imaging (ESSI)*

#### **Macres Award-Best Instrumentation/Software Paper**

R. P. Dougherty; OptiNav, Inc.; K.-H. Kunzelmann; Ludwig-Maximilians-Universität, Munich, Germany  
*Computing Local Thickness of 3D Structures with ImageJ*

#### **Cosslett Award-Best Invited Paper**

S. Jesse, B. Rodriguez, A. P. Baddorf, S.V. Kalinin; Oak Ridge National Laboratory; M. Alexe; Max-Planck-Institut für MikrostrukturPhysik, Halle, Germany  
*Mapping the Nucleation and Growth of Ferroelectric Domains using Switching Spectroscopy Piezoresponse Force Microscopy*

#### **Castaing Award-Best Student Paper**

H. Demers, R. Gauvin; McGill University, Canada  
*A General X-ray Fluorescence Correction for Electron Microanalysis by Monte Carlo Simulations*



### Previous Award Winners

#### Science

1977 R. Castaing  
1978 K. F. J. Heinrich  
1979 P. Duncumb  
1980 D. B. Wittry  
1981 S. J. B. Reed  
1982 R. Shimizu  
1983 J. Philibert  
1984 L. S. Birks  
1985 E. Lifshin  
1986 R. L. Mykleburst  
1987 O. C. Wells  
1988 J. D. Brown  
1989 J. Hillier  
1990 T. E. Everhart  
1991 J. I. Goldstein  
1992 G. W. Lorimer  
G. Cliff  
1993 D. E. Newbury  
1994 D. C. Joy  
1995 G. Bastin  
1996 A. V. Somlyo  
A. P. Somlyo  
1997 D. B. Williams  
1998 F. H. Schamber  
1999 R. A. Sareen  
2000 R. F. Egerton  
2001 P. E. Batson  
2002 K. Keil  
2003 P. E. Russell  
2004 J. T. Armstrong  
2005 G. Slodzian  
2006 B. J. Griffin  
2007 R. D. Leapman

#### Service

1977 P. Lublin  
1978 D. R. Beaman  
1979 M. A. Giles  
1980 A. A. Chodos  
1981 R. L. Myklebust  
1982 J. Doyle  
1983 D. E. Newbury  
1984 J. I. Goldstein  
1985 M. C. Finn  
1986 V. Shull  
1987 D. C. Joy  
1988 C. G. Cleaver  
1989 W. F. Chambers  
1990 C. E. Fiori  
1991 T. G. Huber  
1992 E. S. Etz  
1993 H. A. Freeman  
1994 J. L. Worrall  
1995 R. W. Linton  
1996 P. F. Hlava  
1997 J. A. Small  
1998 J. J. McCarthy  
1999 T. G. Huber  
2000 R. B. Marinenko  
2001 C. E. Lyman  
2002 J. F. Mansfield  
2003 I. H. Musselman  
2004 J. R. Michael  
2005 G. P. Meeker  
2006 H. A. Freeman  
2007 P. K. Carpenter

#### K. F. J. Heinrich

1986 P. J. Statham  
1987 J. T. Armstrong  
1988 D. B. Williams  
1989 R. D. Leapman  
1990 R. W. Linton  
1991 A. D. Romig, Jr.  
1992 S. J. Pennycook  
1993 P. E. Russell  
1994 J. R. Michael  
1995 E. N. Lewis  
1997 R. Gauvin  
1998 V. P. Dravid  
1999 J. Bruley  
2000 H. Ade  
2001 C. Jacobsen  
2002 D. A. Wollman  
2005 M. Watanabe  
2006 M. Toth  
2007 G. Kothleitner

#### P. Duncumb

2007 D. B. Williams